

RL78/F23, F24

Option Byte Setting

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Introduction

This application note describes the setting of Option Byte (User Option Byte, On-chip Debug Option Byte, and Security Option Byte) and issues to be considered when setting them for RL78/F23, F24 products.

For details, be sure to refer to User's Manual: Hardware.

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1. Option Byte for RL78/F23, F24

The Option Byte of RL78/F23, F24 are located in the flash memory 000C0H to 000C4H. Option Byte contains of User Option Byte (000C0H to 000C2H), On-chip Debug Option Byte (000C3H), and Security Option Byte (000C4H), device automatically refers to these value in advance at power on reset released and controls the corresponding function.

When using boot swap function, set boot cluster 0 (000C0H to 000C4H) and boot cluster 1 (040C0H to 040C4H) to the same value in order to switch boot cluster 0 (00000H to 03FFFH) and boot cluster 1 (04000H to 07FFFH).

Figure 1-1 shows the option byte placement area for RL78/F23, F24 products.

This document provides some notes when using the RL78/F23 and F24 option byte function.

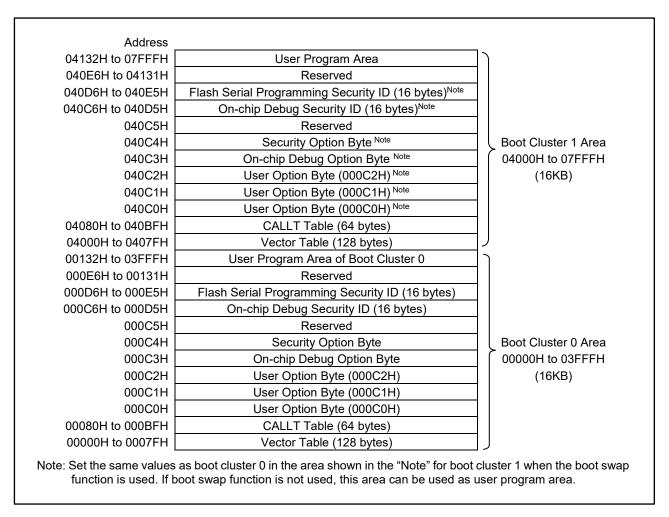


Figure 1-1 Usage area of RL78/F23, F24 Option Byte function

1.1 User Option Byte (000C0H)

User Option Byte (000C0H) controls the operation of watch-dog timer. Bits of User Option Byte (000C0H) are shown in Figure 1-2, and the notes on setting are shown in Table 1-1.

b7	b6	b5	b4	b3	b2	b1	b0
WDTINT	WINDOW [1:0]		WDTON		WDCS [2:0]		WDSTBYON

Bit	Bit Name	Bit Description
7	WDTINT	0: Interval interrupt of watchdog timer is not used
		1: Interval interrupt of watchdog timer is used
6-5	WINDOW [1:0]	01B: Watchdog timer window open period: 50%
		10B: Watchdog timer window open period: 75% Note 2
		11B: Watchdog timer window open period: 100%
		00B: Setting prohibited
4	WDTON	0: Watchdog counter operation disabled (counting stopped after reset)
		1: Watchdog counter operation enabled (counting started after reset)
3-1	WDCS [2:0]	Watchdog timer over-flow time select bits (Count source: fwpt Note1)
		000В: 2 ⁶ /fwdt, 001В: 2 ⁷ /fwdt, 010В: 2 ⁸ /fwdt, 011В: 2 ⁹ /fwdt,
		100B: 2 ¹¹ /fwdt, 101B: 2 ¹³ /fwdt, 110B: 2 ¹⁴ /fwdt, 111B: 2 ¹⁶ /fwdt
0	WDSTBYON	0: Counter operation stopped in HALT / STOP / SNOOZE mode
		1: Counter operation enabled in HALT / STOP / SNOOZE mode

Note: 1. Oscillator characteristics of fwpt (WDT dedicated low-speed on-chip oscillator clock frequency) is (TYP.)

15 kHz. To clear the watchdog timer counter, perform within the range of the oscillator characteristic of fwpt

2. When the window open period is set to 75%, clearing the counter of the watchdog timer (writing ACH to WDTE) must proceed outside the corresponding period from among those listed below, over which clearing of the counter is prohibited (for example, confirming that the interval timer interrupt request flag (WDTIIF) of the watchdog timer is set).

WDCS2	WDCS1	WDCS0	Watchdog timer overflow time (fwpt = 17.25 kHz (MAX.))	Period over which clearing the counter is prohibited when the window open period is set to 75%
0	0	0	2 ⁶ /fwDт (3.71 ms)	1.85 ms to 2.51 ms
0	0	1	2 ⁷ /fwpt (7.42 ms)	3.71 ms to 5.02 ms
0	1	0	28/fwpt (14.84 ms)	7.42 ms to 10.04 ms
0	1	1	2 ⁹ /fwDт (29.68 ms)	14.84 ms to 20.08 ms
1	0	0	2 ¹¹ /fwpt (118.72 ms)	59.36 ms to 80.32 ms
1	0	1	2 ¹³ /fwpt (474.89 ms)	237.44 ms to 321.26 ms
1	1	0	2 ¹⁴ /fwpt (949.79 ms)	474.89 ms to 642.51 ms
1	1	1	2 ¹⁶ /fwpt (3799.18 ms)	1899.59 ms to 2570.04 ms

Figure 1-2. User Option Byte (000C0H)

Table 1-1. Notes of User Option Byte (000C0H) Setting

Bit Name	Note of Setting
WDSTBYON	•The window open period is 100% when WDSTBYON = 0, regardless the value of the WINDOW1
	and WINDOW0 bits.
WDCS [2:0]	Clear the counter within the window open period. (set by WINDOW [1:0] bits)
WDTON	•The invalid memory access detection function is always enabled when this bit is 1, regardless of the
	setting of the IAWEN bit of IAWCTL register. When not using the watchdog timer, clear this bit to 0.
WINDOW [1:0]	•Be sure to set any of 01B, 10B, and 11B.
	•When using the window open period 75% setting, there is a watchdog timer counter clear prohibition period. For details, see Note 2 in Figure 1-2.
	•If "WDSTBYON = 0" is set, the window open period will be 100% regardless of the setting of these
	bits.
WDTINT	•Set this bit to 1 when use interval interrupt of watchdog timer and judging the interrupt request by
	the WDTIF flag of IF0L register.

Caution: Set the same value as 000C0H to 040C0H when the boot swap operation is used.

1.2 User Option Byte (000C1H)

In the User Option Byte (000C1H), set the operation mode of the voltage detector and the operation of the clock monitor function. Bits of User Option Byte (000C1H) are shown in Figure 1-3, and the notes on setting are shown in Table 1-5.

b	7 b6	b5	b4	b3	b2	b1	b0		
	VPOC [2:0]		CLKMB	LVIS	[1:0]	LVIME	S [1:0]		
Bit	Bit Name			Bit De	scription				
7-5 VPOC [2:0] It depends on the operation mode of the used LVD (set by LVIMDS [1:0]) Refer to Table 1-2 and Table 1-3.					[1:0]).				
4	CLKMB	Clock monitor operation is enabled Clock monitor operation is stopped							
3-2	LVIS [1:0]		It depends on the operation mode of the used LVD (set by LVIMDS [1:0]). Refer to Table 1-2 and Table 1-3.						
1-0 LVIMDS [1:0] Set the operation mode of voltage detector 01B: Interrupt mode 10B: Interrupt & reset mode 11B: Reset mode 00B: Setting prohibited									

Figure 1-3. User Option Byte (000C1H)

Table 1-2. Setting of VPOC [2:0] bits and LVIS [1:0] bits when Interrupt mode Note 1 and Reset mode

VPOC [2:0]	LVIS[1:0]	Function
000B	01B	Select the VLVD4
		Grade-3 product: Rise: 3.02 V [2.95 V - 3.09 V], Fall: 2.96 V [2.89 V - 3.02 V]
		Grade-4 product: Rise: 3.02 V [2.95 V - 3.17 V], Fall: 2.96 V [2.89 V - 3.09 V]
		Grade-5 product: Rise: 3.02 V [2.95 V - 3.44 V], Fall: 2.96 V [2.89 V - 3.31 V]
001B	00B	Select the V _{LVD2}
		Grade-3 product: Rise: 4.42 V [4.30 V - 4.51 V], Fall: 4.32 V [4.21 V - 4.41 V]
		Grade-4 product: Rise: 4.42 V [4.30 V - 4.61 V], Fall: 4.32 V [4.21 V - 4.51 V]
		Grade-5 product: Rise: 4.42 V [4.30 V - 4.92 V], Fall: 4.32 V [4.21 V - 4.76 V]
010B	00B	Select the VLVD1
		Grade-3 product: Rise: 4.62 V [4.50 V - 4.72 V], Fall: 4.52 V [4.40 V - 4.62 V]
		Grade-4 product: Rise: 4.62 V [4.50 V - 4.82 V], Fall: 4.52 V [4.40 V - 4.71 V]
		Grade-5 product: Rise: 4.62 V [4.50 V - 5.12 V], Fall: 4.52 V [4.40 V - 4.98 V]
011B	00B	Select the VLVD0
		Grade-3 product: Rise: 4.74 V [4.62 V - 4.84 V], Fall: 4.64 V [4.52 V - 4.74 V]
		Grade-4 product: Rise: 4.74 V [4.62 V - 4.94 V], Fall: 4.64 V [4.52 V - 4.84 V]
		Grade-5 product: Rise: 4.74 V [4.62 V - 5.25 V], Fall: 4.64 V [4.52 V - 5.11 V]
	01B	Select the VLVD3
		Grade-3 product: Rise: 3.22 V [3.13 V - 3.29 V], Fall: 3.15 V [3.07 V - 3.22 V]
		Grade-4 product: Rise: 3.22 V [3.13 V - 3.39 V], Fall: 3.15 V [3.07 V - 3.31 V]
		Grade-5 product: Rise: 3.22 V [3.13 V - 3.66 V], Fall: 3.15 V [3.07 V - 3.52 V]
	11B	Select the V _{LVD5} Note 2
		Grade-3 product: Rise: 2.81 V [2.74 V - 2.87 V], Fall: 2.75 V [2.68 V - 2.81 V]
		Grade-4 product: Rise: 2.81 V [2.74 V - 2.95 V], Fall: 2.75 V [2.68 V - 2.88 V]
		Grade-5 product: Rise: 2.81 V [2.74 V - 3.22 V], Fall: 2.75 V [2.68 V - 3.06 V]
Other tha	n above	Setting prohibited

Notes: 1. If interrupt mode is used (LVIMDS [1:0] = 01B), the reset voltage (at falling voltage) is VPDR (TYP. 1.55 V). In this case the VPDR will be out of the specified operation voltage for this product. After the occurrence of an interrupt (INTLVI), disable other interrupt factors as long as the power supply voltage is within the valid operation range (*) and shift to STOP mode, or generate an internal reset by user software (execution of illegal instruction, reset of watchdog timer function). When supply voltage exceeds selected VLVD, STOP mode or reset state is released. (*). Use operating conditions (VDD (supply voltage): 2.7 V to 5.5 V, fclk (CPU / Peripheral hardware clock frequency): 15 kHz to 40 MHz).

2. In this condition, reset mode can be set, but interrupt mode is prohibited.

Table 1-3. Setting of VPOC [2:0] bits and LVIS [1:0] bits when Interrupt & Reset mode

VPOC [2:0]	LVIS [1:0]	Function
001B	00B	Select the V _{LVD2}
		Grade-3 product: Reset: 2.75 V [2.68 V - 2.81 V], Reset release: 4.42 V [4.30 V - 4.51 V]
		Interrupt (V _{LVDH} : 4.42 V [4.30 V - 4.51 V], V _{LVDL} : 4.32 V [4.21 V - 4.41 V])
		Grade-4 product: Reset: 2.75 V [2.68 V - 2.88 V], Reset release: 4.42 V [4.30 V - 4.61 V]
		Interrupt (VLVDH: 4.42 V [4.30 V - 4.61 V], VLVDL: 4.32 V [4.21 V - 4.51 V])
		Grade-5 product: Reset: 2.75 V [2.68 V - 3.06 V], Reset release: 4.42 V [4.30 V - 4.92 V]
		Interrupt (V _{LVDH} : 4.42 V [4.30 V - 4.92 V], V _{LVDL} : 4.32 V [4.21 V - 4.76 V])
010B	00B	Select the V _{LVD1}
		Grade-3 product: Reset: 2.75 V [2.68 V - 2.81 V], Reset release: 4.62 V [4.50 V - 4.72 V]
		Interrupt (V _{LVDH} : 4.62 V [4.50 V - 4.72 V], V _{LVDL} : 4.52 V [4.40 V - 4.62 V])
		Grade-4 product: Reset: 2.75 V [2.68 V - 2.88 V], Reset release: 4.62 V [4.50 V - 4.82 V]
		Interrupt (V _{LVDH} : 4.62 V [4.50 V - 4.82 V], V _{LVDL} : 4.52 V [4.40 V - 4.71 V])
		Grade-5 product: Reset: 2.75 V [2.68 V - 3.06 V], Reset release: 4.62 V [4.50 V - 5.12 V]
		Interrupt (V _{LVDH} : 4.62 V [4.50 V - 5.12 V], V _{LVDL} : 4.52 V [4.40 V - 4.98 V])
011B	00B	Select the V _L VD0
		Grade-3 product: Reset: 2.75 V [2.68 V - 2.81 V], Reset release: 4.74 V [4.62 V - 4.84 V]
		Interrupt (V _{LVDH} : 4.74 V [4.62 V - 4.84 V], V _{LVDL} : 4.64 V [4.52 V - 4.74 V])
		Grade-4 product: Reset: 2.75 V [2.68 V - 2.88 V], Reset release: 4.74 V [4.62 V - 4.94 V]
		Interrupt (V _{LVDH} : 4.74 V [4.62 V - 4.94 V], V _{LVDL} : 4.64 V [4.52 V - 4.84 V])
		Grade-5 product: Reset: 2.75 V [2.68 V - 3.06 V], Reset release: 4.74 V [4.62 V - 5.25 V]
045		Interrupt (V _{LVDH} : 4.74 V [4.62 V - 5.25 V], V _{LVDL} : 4.64 V [4.52 V - 5.11 V])
	01B	Select the VLVD3
		Grade-3 product: Reset: 2.75 V [2.68 V - 2.81 V], Reset release: 3.22 V [3.13 V - 3.29 V] Interrupt (V _{LVDH} : 3.22 V [3.13 V - 3.29 V], V _{LVDL} : 3.15 V [3.07 V - 3.22 V])
		Grade-4 product: Reset: 2.75 V [2.68 V - 2.88 V], Reset release: 3.22 V [3.13 V - 3.39 V]
		Interrupt (V _{LVDH} : 3.22 V [3.13 V - 3.39 V], V _{LVDL} : 3.15 V [3.07 V - 3.31 V])
		Grade-5 product: Reset: 2.75 V [2.68 V - 3.06 V], Reset release: 3.22 V [3.13 V - 3.66 V]
		Interrupt (V _{LVDH} : 3.22 V [3.13 V - 3.66 V], V _{LVDL} : 3.15 V [3.07 V - 3.52 V])
Other tha	ı an ahove	Setting prohibited
Other than above		Cotting promoted

Table 1-4. Setting of VPOC [2:0] bits and LVIS [1:0] bits when LVD off

VPOC [2:0]	LVIS [1:0]	LVIMDS [1:0]	Function
111B	00B	11B	LVD off

Table 1-5. Notes of User Option Byte (000C1H) setting

Bit Name	Note of Setting					
LVIMDS [1:0]	Do not set 00B to these bits.					
	•If do not use the LVD circuit, set 11B.					
	•If use 01B (Interrupt mode), do not select VLVD5.					
LVIS [1:0]	•If do not use the LVD circuit, set 00B.					
	•Use the Interrupt mode, Reset mode: Refer to Table 1-2.					
	•Use the Interrupt & Reset mode: Refer to Table 1-3.					
CLKMB	•To use the clock monitor function, set this bit to 0.					
VPOC [2:0]	•If do not use the LVD circuit, set 111B.					
	•The LVD circuit is used, not set values other than 000B, 001B, 010B, 011B.					

Cautions: 1. The setting when not using the LVD circuit is refer to Table 1-4. And have a reset circuit on user's system.

2. Set the same value as 000C1H to 040C1H when the boot swap operation is used.

1.3 User Option Byte (000C2H)

User Option Byte (000C2H) sets the frequency of high-speed on-chip oscillator, and P130/RESOUT pin operation mode. Bits of User Option Byte (000C2H) are shown in Figure 1-4, and the notes on setting are shown in Table 1-6.

b7	b6	b5	b4	b3	b2	b1	b0
1	1	RESOUTB			FRQSEL [4:0]		

Bit	Bit Name	Bit Description
7-6	•	Be sure to set these bits to 11B. Setting of other values is prohibited.
5	RESOUTB	0: Selects P130 as the RESOUT pin
		1: Selects P130 as a general port pin (output only)
4-0	FRQSEL [4:0]	Set the frequency of high-speed on-chip oscillator.
		(Following table)

FRQSEL4	FRQSEL3	FRQSEL2	FRQSEL1	FRQSEL0	high-speed on-chip oscillator frequency
1	1	0	0	0	80 MHz
1	0	0	0	0	64 MHz
0	1	0	0	0	40 MHz
0	0	0	0	0	32 MHz
0	1	0	0	1	20 MHz
0	0	0	0	1	16 MHz
0	0	0	1	0	8 MHz
0	0	0	1	1	4 MHz
0	0	1	0	0	2 MHz
	Othe	r than those a	above:		Setting prohibited

Figure 1-4. User Option Byte (000C2H)

Table 1-6. Notes of User Option Byte (000C2H) setting

Bit Name	Note of Setting
FRQSEL [4:0]	• Be sure to set one of 00000B, 00001B, 00010B, 00011B, 00100B, 01000B, 01001B, 10000B,
	11000B.
RESOUTB	 P130/RESOUT pin is not available for 32-pin product. When using 32-pin product, it is recommended that this bit be set to the initial value ("1"). P130 pin outputs low-level during reset regardless of the setting of this bit. When this bit is set to 0, P130/RESOUT pin automatically outputs High-level after reset release. Regardless of port latch (P130 bit), high-level is output until it is reset.
b6	Be sure to write this bit to 1.
b7	Be sure to write this bit to 1.

Caution: Set the same value as 000C2H to 040C2H when the boot swap operation is used.

1.4 On-chip Debug Option Byte (000C3H)

On-chip Debug Option Byte (000C3H) sets the operation when debugger is connected. Bits of on-chip Debug Option Byte (000C3H) are shown in Figure 1-5, and the notes on setting are shown in Table 1-8.

h7	b6	h5	h4	h2	h2	h1	b0
OCDENSET	0	FLPEN	0	0	1	HPIEN	0CDERSD

Bit	Bit Name	Bit Description			
7	OCDENSET	Control in on-chip debug operation with OCDERSD bit.			
		Refer to Table 1-7.			
6	-	Be sure to write "0" for this bit. If write "1", the operation is not guaranteed.			
5	FLPEN	Controls flash serial programming and on-chip debug operations.			
		0: Operation disabled			
		1: Operation enabled (Refer to Table 1-7 in on-chip debug function)			
4-2	-	Be sure to write "001B" for these bits. Do not set other value.			
1	HPIEN	Control hot plug-in operation.			
		Refer to Table 1-7.			
0	OCDERSD	Control on-chip debug operation with OCDENSET.			
		Refer to Table 1-7.			

Figure 1-5. On-chip Debug Option Byte (000C3H)

Table 1-7. Setting of OCDENSET, HPIEN, OCDERSD bits

OCDENSET	HPIEN	OCDERSD	Function
0	0	0	Disables on-chip debug operation Note1
1	0	0	Enables on-chip debugging and disables hot plug-in operation. Erases data of flash memory Note3 in case of failures in authenticating on-chip debug security ID Note2.
1	0	1	Enables on-chip debugging and disables hot plug-in operation. Does not erase data of flash memory Note3 in case of failures in authenticating on-chip debug security ID Note2.
1	1	1	Enables on-chip debugging and hot plug-in operation. Does not erase data of flash memory Note3 in case of failures in authenticating on-chip debug security ID Note2.
Other than above		'e	Setting prohibited

Notes

- 1. When using the flash programmer, Erase / Program of flash memory can be performed.
- 2. The security ID is the 16-byte ID located at 000C6H to 000D5H.
- 3. Both code flash memory and data flash memory are targeted.

Caution: When FLPEN=0, the on-chip debug function is disable regardless of the OCDENSET setting.

Table 1-8. Notes of On-chip Debug Option Byte (000C3H) Setting

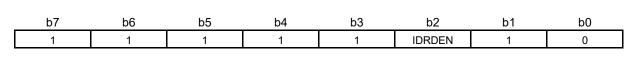
Bit Name	Note of Setting				
OCDERSD	•Do not set 1 to OCDERSD bit when OCDENSET bit is 0.				
HPIEN Note	•When the HPIEN bit is set to 1, the f _{IL} (low-speed on-chip oscillator) operates and cannot be				
	stopped by the user program. The f _{IL} can be stopped by register setting only in standby mode.				
	For details, refer to User's Manual: Hardware.				
b4 to b2 Note	•Be sure to set these bits to 001B.				
FLPEN	•When the FLPEN bit is set to 0, flash serial programming function and on-chip debug function are				
	disabled. Note that flash memory can only be rewritten by self-programming.				
b6	•Be sure to set "0".				
OCDENSET	•Do not set 0 to OCDENSET bit when OCDERSD bit is 1.				

Note: When on-chip debug function is used, HPIEN and bit 3 to 2 changes bits value to other. Be sure to write 01B when writing to these bits.

Caution: Set the same value as 000C3H to 040C3H when the boot swap operation is used. When using on-chip debugging and hot plug-in functions, some internal RAM area cannot be used depending on the product. Refer to User's Manual: Hardware.

1.5 Security Option Byte (000C4H)

Security Option Byte (000C4H) can mask the reading of the ID area (On-chip Debug Security ID and Flash Serial Programing Security ID). Bit of Security Option Byte (000C4H) are shown in Figure 1-6, and the notes on setting are shown in Table 1-9.



Bit	Bit Name	Bit Description
7-3	-	Be sure to set these bits to 11111B. Setting of other values is strictly prohibited.
2	IDRDEN	On-chip Debug Security ID (000C6H to 000D5H) and Flash Serial Programming Security ID (000D6H to 000E5H) control the read operation. 0: Read operation disabled (When reading, readable "0") 1: Read operation enabled
1-0	•	Be sure to write "10B". Setting of other values is strictly prohibited.

Figure 1-6. Security Option Byte (000C4H)

Table 1-9. Notes of Security Option Byte (000C4H) setting

Bit Name	Note of Setting
b1, b0	Be sure to set these bits to 10B.
IDRDEN	 When IDRDEN is set to "0", on-chip debug security ID and Flash serial programming security ID are readable "0". Even if IDRDEN is set to "0", reading to the area of 040C6H to 040D5H, and 040D6H to 040E5H is not prohibited. Even if IDRDEN is set to "0", the high-speed CRC function can read the value and calculates the CRC. When IDRDEN is set to "0", be sure to enable the prohibition of rewriting boot cluster 0 (00000H to 3FFFFH).
b7 to b3	Be sure to set these bits to 11111B.

Cautions:

- 1. The setting of prohibition of rewriting boot cluster 0 refer to the flash memory section in RL78/F23, F24 User's manual (Hardware).
- 2. Set the same value as 000C4H to 040C4H when the boot swap operation is used.

2. Setting Range of Option Byte for RL78/F23, F24

The setting range of Option Bytes are shown in the Table 2-1.

Table 2-1. Setting Range of Option Byte

		RL78/F23, F24			
Option Bytes		V _{DD} = 2.7 V to 5.5 V, f _{CLK} = 15 kHz to 40 MHz,			
		$T_A = -40 ^{\circ}\text{C}$ to 105 $^{\circ}\text{C}$ (Grade-3), $T_A = -40 ^{\circ}\text{C}$ to 125 $^{\circ}\text{C}$ (Grade-4), $T_A = -40 ^{\circ}\text{C}$ to 150 $^{\circ}\text{C}$ (Grade-5)			
÷Ξ	WDSTBYON	0 or 1			
000C0H/ 040C0H	WDCS [2:0]	000B to 111B			
000	WDTON	0 or 1			
	WINDOW [1:0]	01B, 10B, or 11B (00B setting prohibited)			
	WDTINT	0 or 1			
テェ	LVIMDS [1:0]	01B, 10B, or 11B (00B setting prohibited)			
000C1H/ 040C1H	LVIS [1:0]	· LVIMDS=01B, VPOC=000B: 01B			
90		·LVIMDS=01B, VPOC=001B: 00B			
		·LVIMDS=01B, VPOC=010B: 00B			
		·LVIMDS=01B, VPOC=011B: 00B, 01B, or 11B			
		·LVIMDS=10B, VPOC=001B: 00B			
		·LVIMDS=10B, VPOC=010B: 00B			
		· LVIMDS=10B, VPOC=011B: 00B or 01B			
		· LVIMDS=11B, VPOC=000B: 01B			
		· LVIMDS=11B, VPOC=001B: 00B			
		· LVIMDS=11B, VPOC=010B: 00B			
		· LVIMDS=11B, VPOC=011B: 00B, 01B, or 11B			
		·LVIMDS=11B, VPOC=111B: 00B			
		(Other than the above: Setting prohibited)			
	CLKMB	0 or 1			
	VPOC [2:0]	· LVIMDS=01B: 000B, 001B, 010B, or 011B			
		· LVIMDS=10B: 001B, 010B, or 011B			
		· LVIMDS=11B: 000B, 001B, 010B, 011B, or 111B (LVD off)			
		(Other than the above: Setting prohibited)			
主エ	FRQSEL [4:0]	00000B, 00001B, 00010B, 00011B, 00100B, 01000B, 01001B, 10000B, or 11000B			
C21		(Other than the above: Setting prohibited)			
000C2H/ 040C2H	RESOUTB	0 or 1			
	bit7, bit6	11B (Setting prohibited except 11B)			
主표	OCDERSD	[OCDENSET, HPIEN, OCDERSD] = 000B, 100B, 101B, or 111B			
000C3H/ 040C3H	HPIEN	(Other than the above: Setting prohibited)			
8 8	OCDENSET				
	FLPEN	0 or 1			
	bit4 to bit2	001B (Setting prohibited except 001B)			
	bit6	0 (1 setting prohibited)			
구 王	IDRDEN	0 or 1			
000C4H/ 040C4H	bit1, bit0	10B (Setting prohibited except 10B)			
% 00	bit7 to bit3	11111B (Setting prohibited except 11111B)			

Caution: When using boot swap operation, set 040C0H-040C4H to the same value as 000C0H-000C4H.

3. References

References documents for this application note are shown below. Be sure to obtain the latest version of each document from the website of Renesas Electronics Corporation when designing.

- · RL78/ F23, F24 User's Manual: Hardware Rev. 1.00
- · RL78 Family User's Manual: Software Rev. 2.30

Revision History

ĺ			Description		
	Rev.	Date	Page	Summary	
ĺ	1.00	2022.09.30	-	First edition issued.	

General Precautions in the Handling of Microprocessing Unit and Microcontroller Unit Products

The following usage notes are applicable to all Microprocessing unit and Microcontroller unit products from Renesas. For detailed usage notes on the products covered by this document, refer to the relevant sections of the document as well as any technical updates that have been issued for the products.

1. Precaution against Electrostatic Discharge (ESD)

A strong electrical field, when exposed to a CMOS device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop the generation of static electricity as much as possible, and quickly dissipate it when it occurs. Environmental control must be adequate. When it is dry, a humidifier should be used. This is recommended to avoid using insulators that can easily build up static electricity. Semiconductor devices must be stored and transported in an anti-static container, static shielding bag or conductive material. All test and measurement tools including work benches and floors must be grounded. The operator must also be grounded using a wrist strap. Semiconductor devices must not be touched with bare hands. Similar precautions must be taken for printed circuit boards with mounted semiconductor devices.

2. Processing at power-on

The state of the product is undefined at the time when power is supplied. The states of internal circuits in the LSI are indeterminate and the states of register settings and pins are undefined at the time when power is supplied. In a finished product where the reset signal is applied to the external reset pin, the states of pins are not guaranteed from the time when power is supplied until the reset process is completed. In a similar way, the states of pins in a product that is reset by an on-chip power-on reset function are not guaranteed from the time when power is supplied until the power reaches the level at which resetting is specified.

3. Input of signal during power-off state

Do not input signals or an I/O pull-up power supply while the device is powered off. The current injection that results from input of such a signal or I/O pull-up power supply may cause malfunction and the abnormal current that passes in the device at this time may cause degradation of internal elements. Follow the guideline for input signal during power-off state as described in your product documentation.

4. Handling of unused pins

Handle unused pins in accordance with the directions given under handling of unused pins in the manual. The input pins of CMOS products are generally in the high-impedance state. In operation with an unused pin in the open-circuit state, extra electromagnetic noise is induced in the vicinity of the LSI, an associated shoot-through current flows internally, and malfunctions occur due to the false recognition of the pin state as an input signal become possible.

5. Clock signals

After applying a reset, only release the reset line after the operating clock signal becomes stable. When switching the clock signal during program execution, wait until the target clock signal is stabilized. When the clock signal is generated with an external resonator or from an external oscillator during a reset, ensure that the reset line is only released after full stabilization of the clock signal. Additionally, when switching to a clock signal produced with an external resonator or by an external oscillator while program execution is in progress, wait until the target clock signal is stable.

6. Voltage application waveform at input pin

Waveform distortion due to input noise or a reflected wave may cause malfunction. If the input of the CMOS device stays in the area between V_{IL} (Max.) and V_{IH} (Min.) due to noise, for example, the device may malfunction. Take care to prevent chattering noise from entering the device when the input level is fixed, and also in the transition period when the input level passes through the area between V_{II} (Max.) and V_{IH} (Min.).

Prohibition of access to reserved addresses

Access to reserved addresses is prohibited. The reserved addresses are provided for possible future expansion of functions. Do not access these addresses as the correct operation of the LSI is not quaranteed.

8. Differences between products

Before changing from one product to another, for example to a product with a different part number, confirm that the change will not lead to problems. The characteristics of a microprocessing unit or microcontroller unit products in the same group but having a different part number might differ in terms of internal memory capacity, layout pattern, and other factors, which can affect the ranges of electrical characteristics, such as characteristic values, operating margins, immunity to noise, and amount of radiated noise. When changing to a product with a different part number, implement a system-evaluation test for the given product.

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